Search Notes

Application/Control No.	Applicant(s)/Patent und r Reexamination	Applicant(s)/Patent und r Reexamination	
09/644,463	HAYCOCK ET AL.		
Examiner	Art Unit		
Raymond Phan	2111		

SEARCHED					
Class	Subclass	Date	Examiner		
710	305-306, 308-315, 104-110	6/3/2006	RP		
710	58-61	6/3/2006	RP		
710	31-38	6/3/2006	RP		
326	83,86-87	6/4/2006	RP		
326	56-58	6/4/2006	RP		
216	20-22	6/4/2006	RP		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	